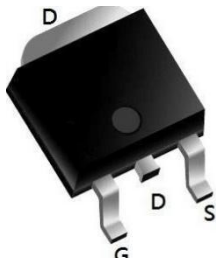
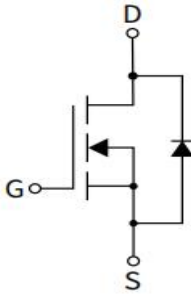


Features ➤ Super Junction technology ➤ Much lower Ron*A performance for On-state efficiency ➤ Better efficiency due to very low FOM ➤ Qualified for industrial grade applications according to JEDEC	Bvdss	Rdson	ID
	650V	398mΩ	11A
	Application ➤ PWM applications ➤ Load Switch ➤ Power management		



Package
  

Marking and pin assignment

TO252-3L top view

Schematic diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Quantity
65R380/HL11N65R	HL11N65R	TO252-3L	2500

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current, $V_{GS}@10V^{1,6}$	I_D	11	A
		7	A
Pulsed Drain Current ²	I_{DM}	44	A
Avalanche Energy, single Pulse ³	E_{AS}	120	mJ
Avalanche current	I_{AS}	11	A
Total Power Dissipation ⁴ @ $T_C = 25^\circ\text{C}$	P_D	29	W
Storage Temperature Range	T_{STG}	-55 ~ 150	$^\circ\text{C}$
Operating Junction Temperature Range	T_J	-55 ~ 150	$^\circ\text{C}$



Thermal Resistance Ratings

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance Junction-Ambient ¹	$R_{\theta JA}$	--	78	°C/W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	--	4.3	°C/W

Ordering Information

Ordering Number	Package	Pin Assignment			Packing
Halogen Free		G	D	S	
HL11N65R	TO252-3L	1	2	3	Tape Reel

Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	650	-	-	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=650V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	-	-	1	μA
		$V_{DS}=650V, V_{GS}=0V, T_J=100^{\circ}\text{C}$	-	-	100	
Gate-Source leakage current	I_{GSS}	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	± 80	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	3.5	-	4.5	V
Static Drain-Source On-Resistance ²	$R_{DS(on)}$	$V_{GS}=10V, I_D=5.5A$	-	398	450	m Ω
Forward Transconductance	g_{fs}	$V_{DS}=20V, I_D=5.5A$	-	12	-	S
Gate Resistance	R_g	$V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$	-	2	-	Ω
Input capacitance	C_{iss}	$V_{DS}=100V, V_{GS}=0V,$ $f=1\text{MHz}$	-	790	-	pF
Output capacitance	C_{oss}		-	32	-	
Reverse transfer capacitance	C_{rss}		-	2	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=400V, I_D=5.5A,$ $R_G=25\Omega, V_{GS}=10V$	-	20	-	ns
Rise time	t_r		-	15	-	
Turn-off delay time	$t_{d(off)}$		-	74	-	
Fall time	t_f		-	43	-	
Gate to source charge	Q_{gs}	$V_{DD}=480V, I_D=5.5A,$ $V_{GS}=10V$	-	5.3	-	nC
Gate to drain charge	Q_{gd}		-	8.8	-	
Gate charge total	Q_g		-	22	-	
Continuous Source Current ^{1,4}	I_S	$V_G=V_D=0V, \text{Force Current}$	-	-	11	A



Diode forward voltage ²	V_{SD}	$V_{GS}=0V, I_S=5.5A, T_J=25^{\circ}C$	-	-	1.2	V
Reverse recovery time	t_{rr}	$I_F=5.5A, di/dt=100A/\mu s, T_J=25^{\circ}C$	-	218	-	ns
Reverse recovery charge	Q_{rr}		-	2.35	-	nC

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed,pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- 3.The EAS data shows Max. rating . The test condition is $T_J=25^{\circ}C, V_{DD}=200V, V_{GS}=10V, L=60mH$.
- 4.The power dissipation is limited by 150 $^{\circ}C$ junction temperature.
- 5.The data is theoretically the same as I_D and I_{DM} ,in real applications,should be limited by total power dissipation.

Typical Performance Characteristics

Fig 1: Output Characteristics ($T_J=25^\circ\text{C}$)

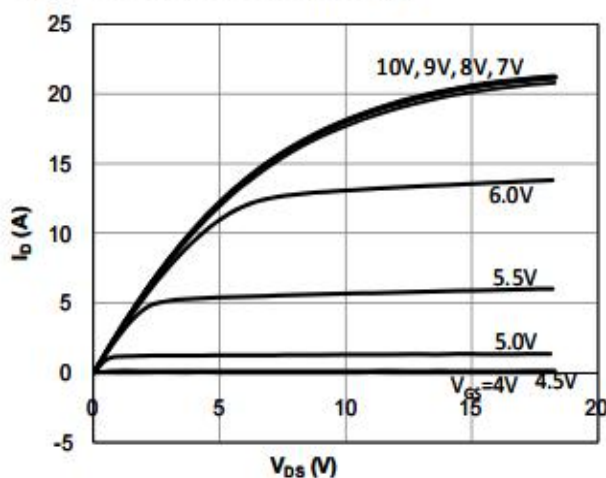


Fig 2: Output Characteristics ($T_J=150^\circ\text{C}$)

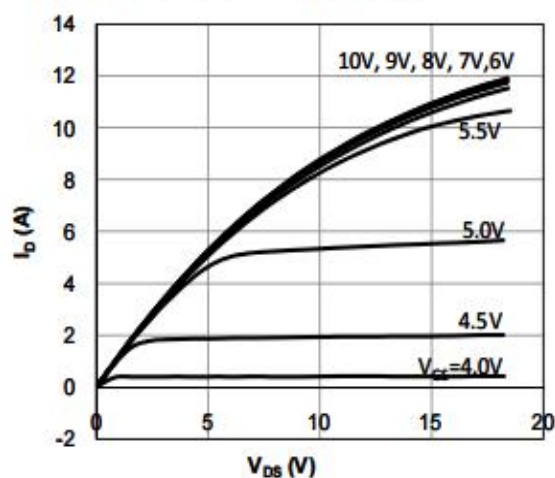


Fig 3: Transfer Characteristics

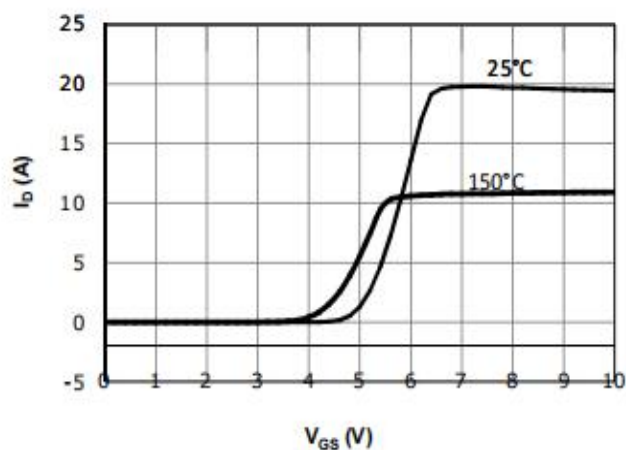


Fig 4: V_{TH} Vs T_J Temperature Characteristics

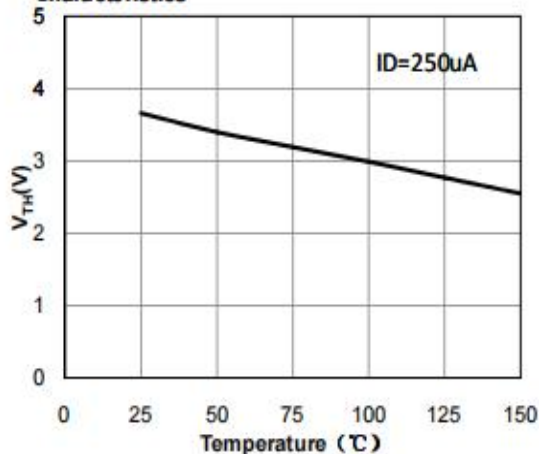


Fig 5: $R_{DS(on)}$ Vs I_{DS} Characteristics ($T_C=25^\circ\text{C}$)

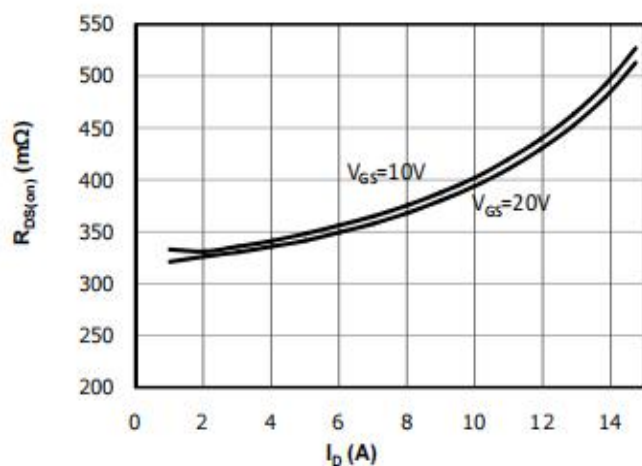


Fig 6: $R_{DS(on)}$ vs. Temperature

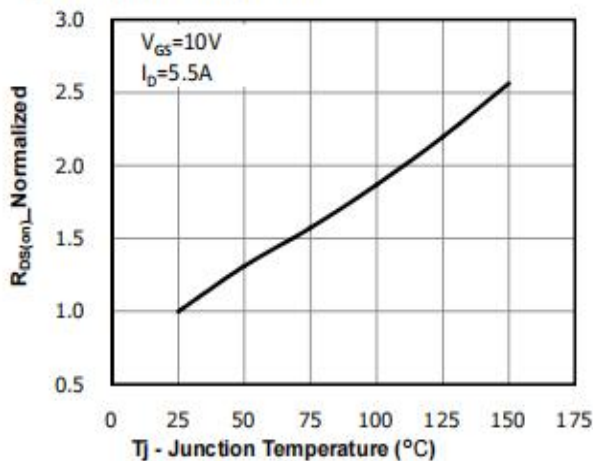


Fig 7: BVDSS vs. Temperature

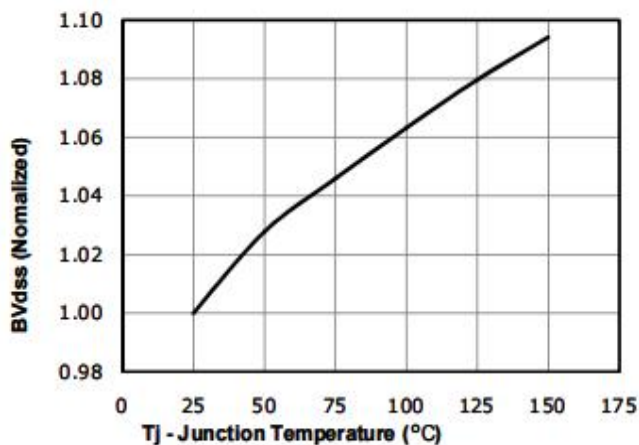


Fig 8: Rds(on) vs Gate Voltage

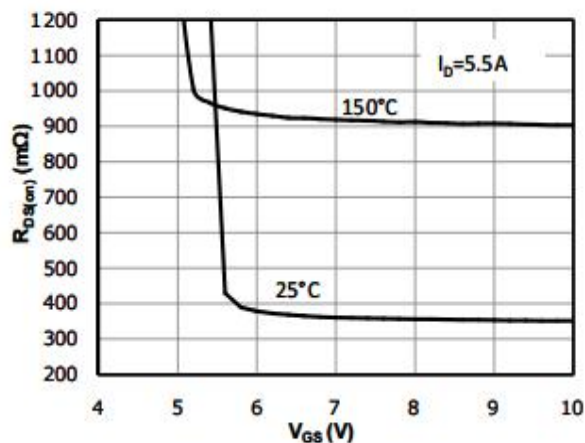


Fig 9: Body-diode Forward Characteristics

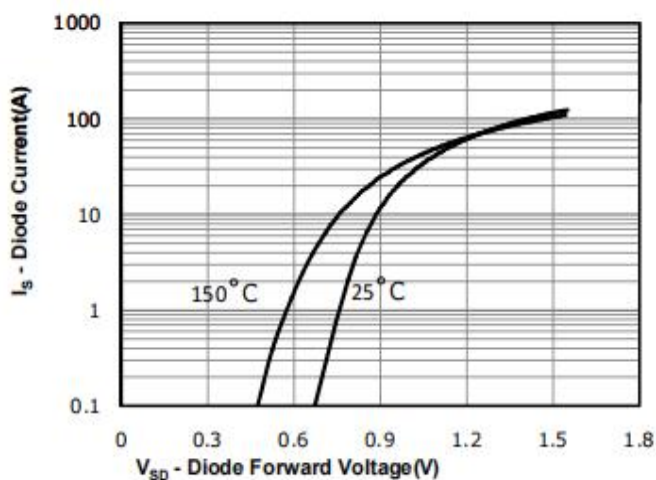


Fig 10: Gate Charge Characteristics

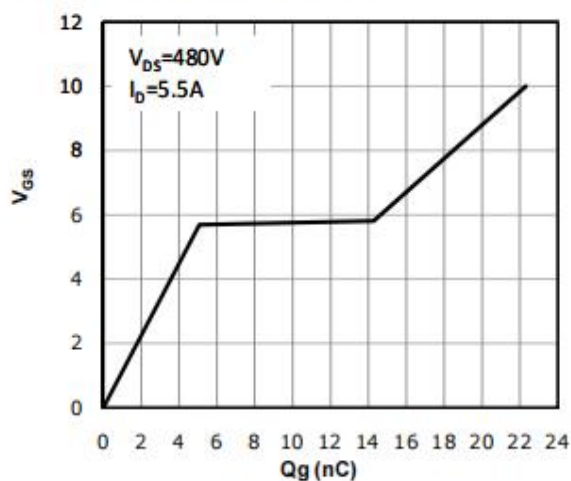


Fig 11: Capacitance Characteristics

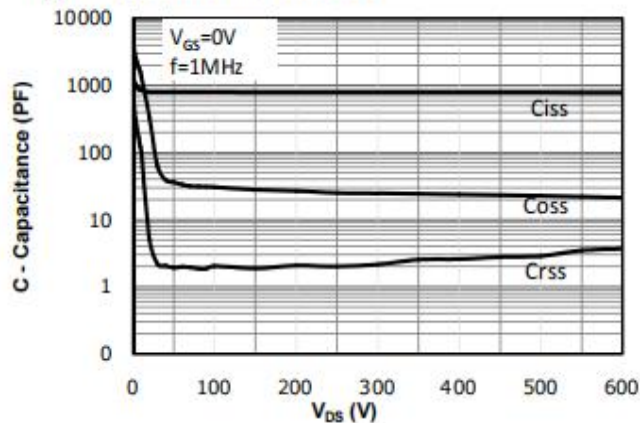


Fig 12: Safe Operating Area

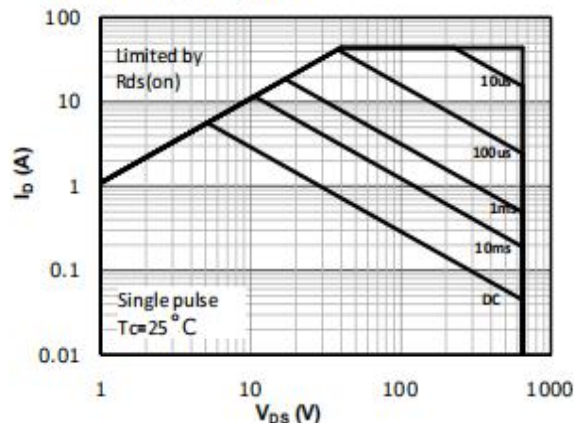
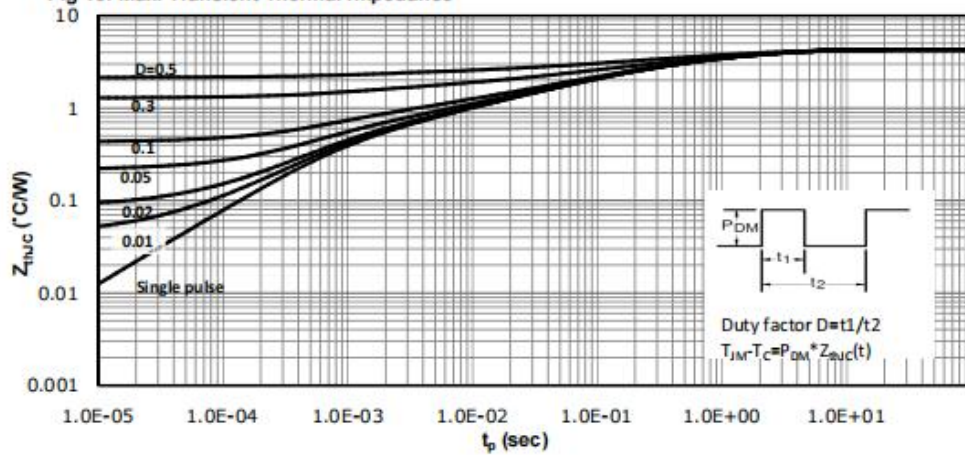
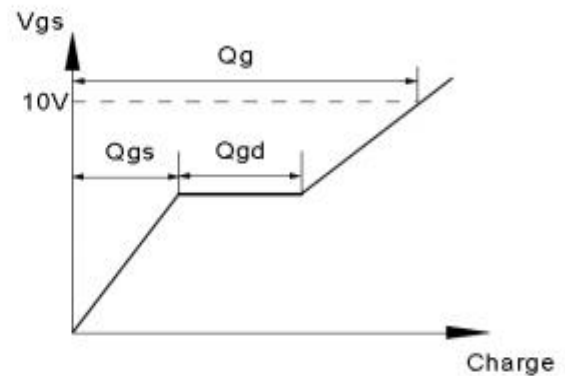
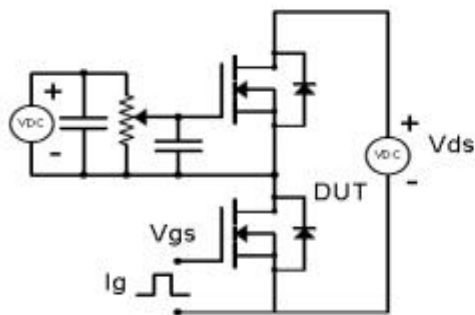


Fig 13: Max. Transient Thermal Impedance

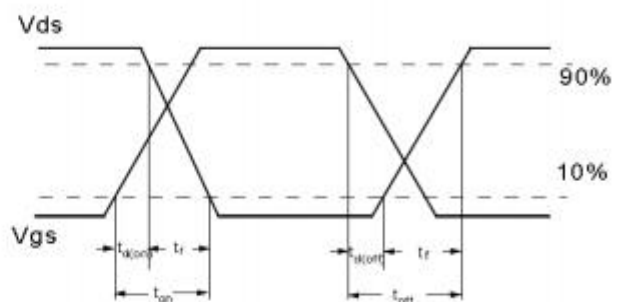
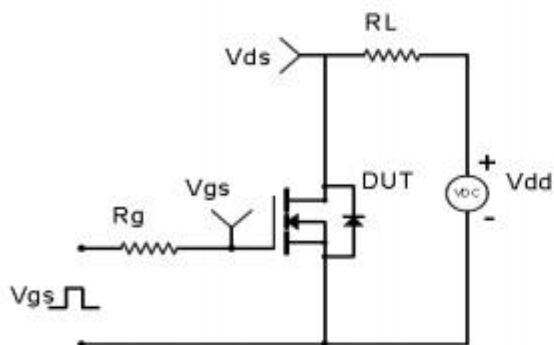


Test Circuit and Waveform

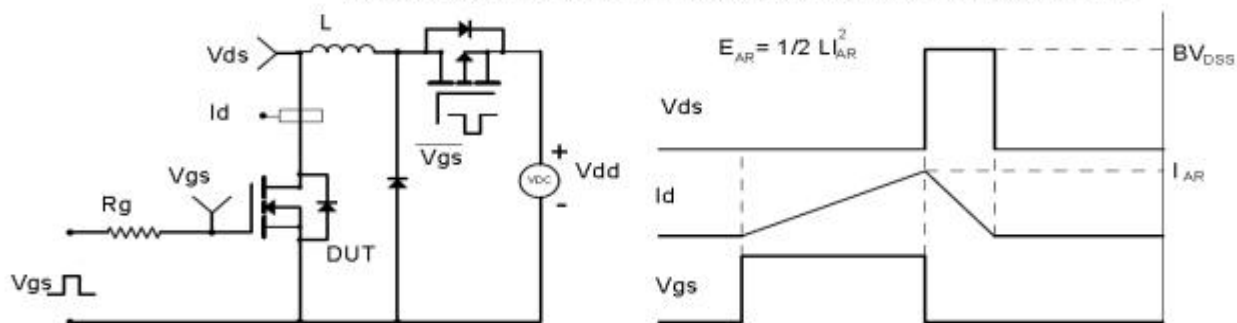
Gate Charge Test Circuit & Waveform



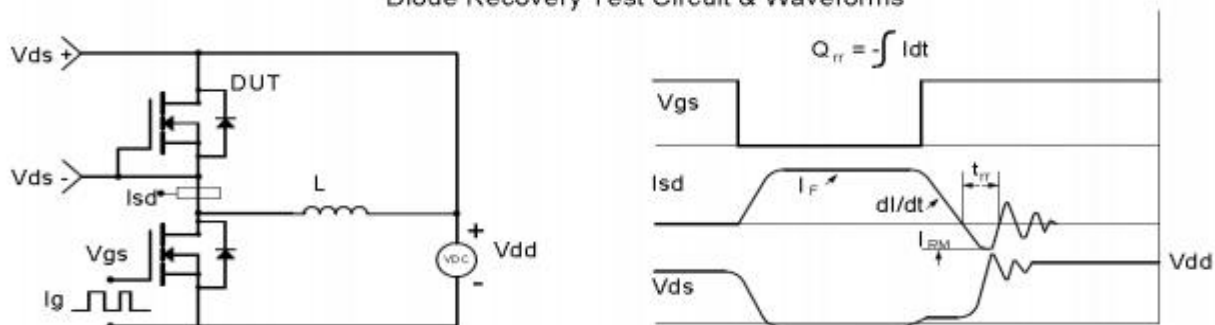
Resistive Switching Test Circuit & Waveforms



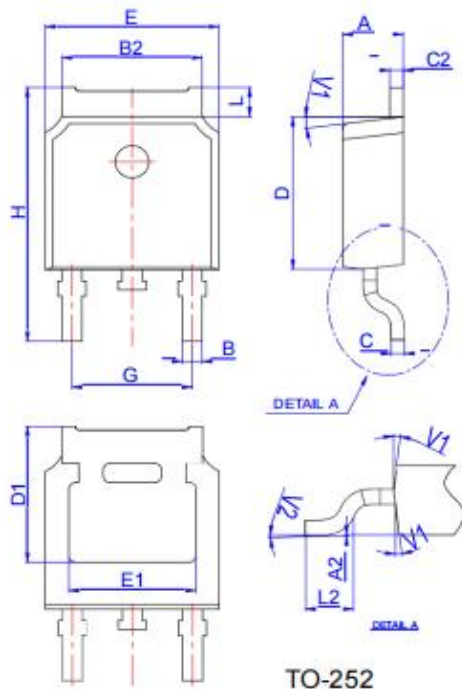
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

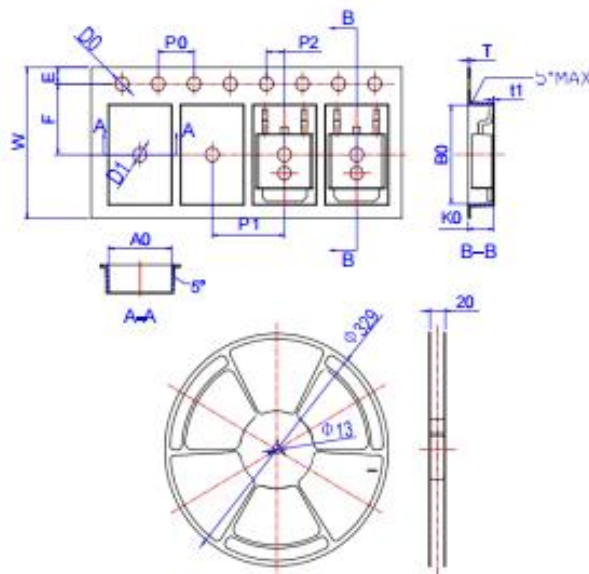


Package Dimensions TO252-3L



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Reel Specification-TO-252-4R



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
B0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
T	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583



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